

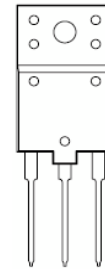


WGFW3N150

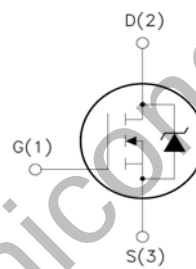
Features:

- ☐ Low Intrinsic Capacitances.
- ☐ Excellent Switching Characteristics.
- ☐ Extended Safe Operating Area.
- ☐ Unrivalled Gate Charge: $Q_g = 64\text{nC}$ (Typ.).
- ☐ $V_{DS} = 1500\text{V}$, $I_D = 3\text{A}$
- ☐ $R_{DS(on)} : 5.8\Omega$ (Max) @ $V_G = 10\text{V}$
- ☐ 100% Avalanche Tested

TO-3PF



1 2 3



- 1. Gate (G)
- 2. Drain (D)
- 3. Source (S)

Absolute Maximum Ratings ($T_a = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Value	Unit
V_{DS}	Drain-Source Voltage	1500	V
I_D	Drain Current	$T_C = 25^\circ\text{C}$	A
		$T_C = 100^\circ\text{C}$	
V_{GSS}	Gate - Source voltage	± 30	V
E_{AS}	Single Pulse Avalanche Energy (note1)	450	mJ
I_{AR}	Avalanche Current (note2)	3	A
P_D	Power Dissipation ($T_j = 25^\circ\text{C}$)	35	W
T_j	Junction Temperature(MAX)	150	$^\circ\text{C}$
T_{stg}	Storage Temperature	$-55 \sim +150$	$^\circ\text{C}$
TL	Maximum lead temperature for soldering purpose, 1/8" from case for 5 seconds	300	$^\circ\text{C}$

Thermal Characteristics

Symbol	Parameter	Typ.	Max.	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case	-	4.4	$^\circ\text{C/W}$
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	-	62.5	$^\circ\text{C/W}$

Electrical Characteristics (Ta= 25°C unless otherwise noted)

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Unit
Off Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0	1500	-	-	V
ΔBVDSS/ΔT _J	Breakdown Voltage Temperature Coefficient	I _D =250μA ,Reference to 25℃	-	0.5	-	V/℃
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =1500V, V _{GS} =0V	-	-	10	μA
		V _{DS} =1500V, T _c =125℃			500	
I _{GSSF}	Gate-body leakage Current, Forward	V _{GS} =+30V, V _{DS} =0V	-	-	100	nA
I _{GSSR}	Gate-body leakage Current, Reverse	V _{GS} =-30V, V _{DS} =0V	-	-	-100	
On Characteristics						
V _{GS(TH)}	Date Threshold Voltage	I _D =250μA, V _{DS} =V _{GS}	3	-	5	V
R _{DS(ON)}	Static Drain-Source On-Resistance	I _D =1.3A, V _{GS} =10V	-	5.1	5.8	Ω
Dynamic Characteristics						
Ciss	Input Capacitance	V _{DS} =25V, V _{GS} =0, f=1.0MHz	-	1450	-	pF
Coss	Output Capacitance		-	101	-	
Crss	Reverse Transfer Capacitance		-	40	-	
Switching Characteristics						
Td(on)	Turn-On Delay Time	V _{DD} =600V, I _D =1.25A R _G =25Ω (Note 3,4)	-	35	-	ns
Tr	Turn-On Rise Time		-	47	-	
Td(off)	Turn-Off Delay Time		-	95	-	
Tf	Turn-Off Rise Time		-	44	-	
Qg	Total Gate Charge	V _{DS} =600V, V _{GS} =10V, I _D =2.5A (Note 3,4)	-	64	-	nC
Qgs	Gate-Source Charge		-	9.1	-	
Qgd	Gate-Drain Charge		-	33	-	
Drain-Source Diode Characteristics and Maximum Ratings						
Is	Max. Diode Forward Current	-	-	-	3	A
ISM	Max. Pulsed Forward Current	-	-	-	10	
VSD	Diode Forward Voltage	ID=2.5A	-	-	1.6	V
Trr	Reverse Recovery Time	IS=2.5A, VGS=0V diF/ dt=100A/μs (Note3)	-	1475	-	nS
Qrr	Reverse Recovery Charge		-	3.53	-	μC

Notes : 1, L=20.8mH, IAS=3A, VDD=50V, RG=25Ω, Starting T_J =25°C

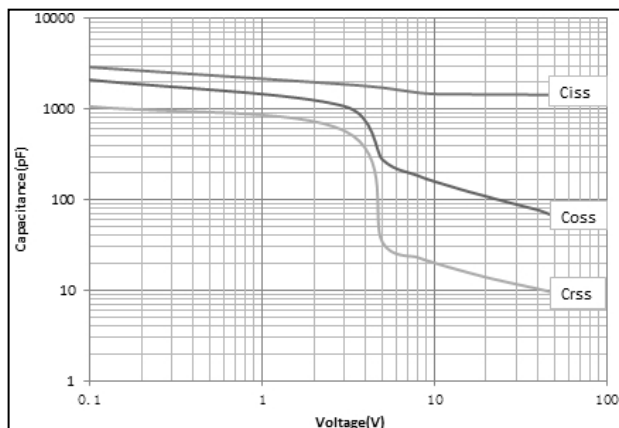
2, Repetitive Rating : Pulse width limited by maximum junction temperature

3, Pulse Test : Pulse Width ≤ 300μs, Duty Cycle ≤ 2%

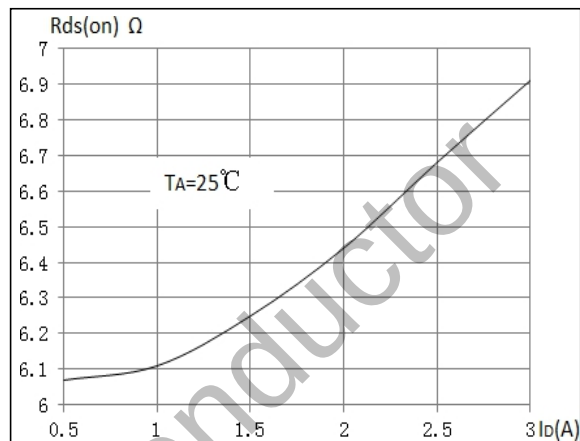
4, Essentially Independent of Operating Temperature

Typical Characteristics

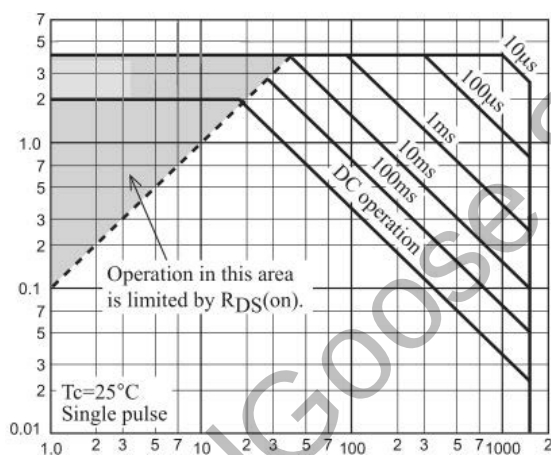
Capacitance Characteristics



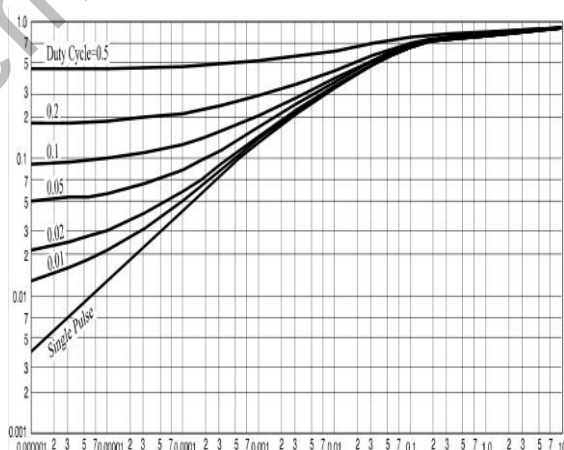
On-Resistance Variation vs. I_D



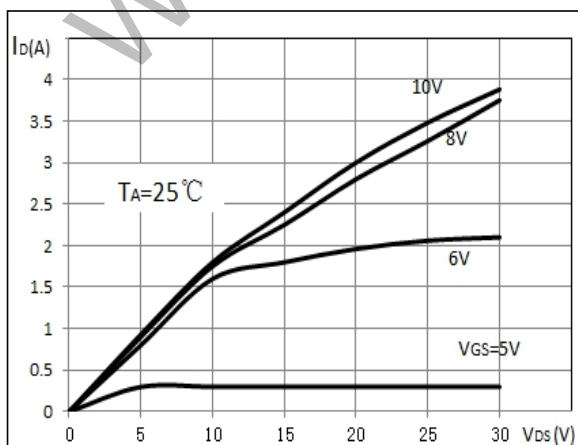
Maximum Safe Operating Area



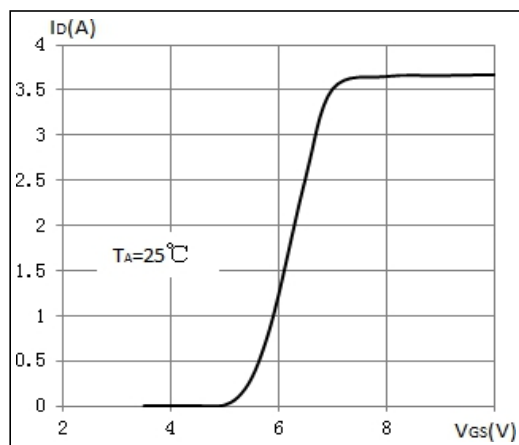
Thermal impedance



Output characteristics

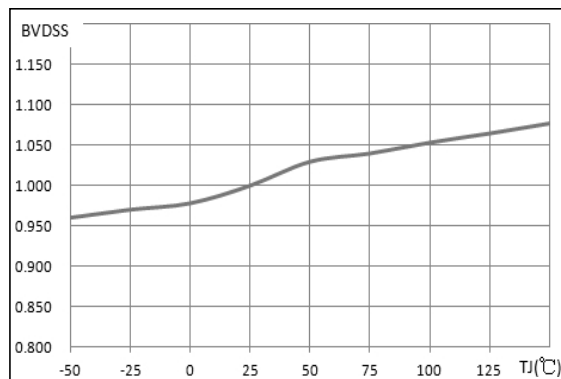


Transfer characteristics

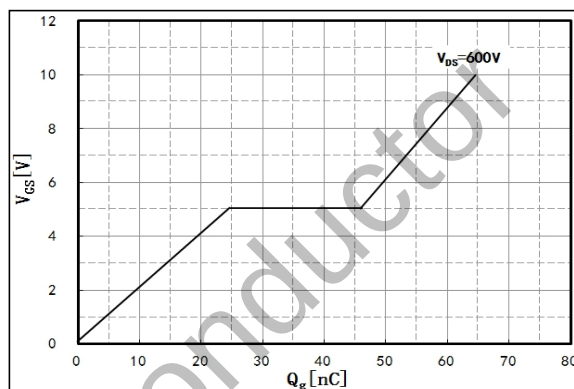


Typical Characteristics (Continued)

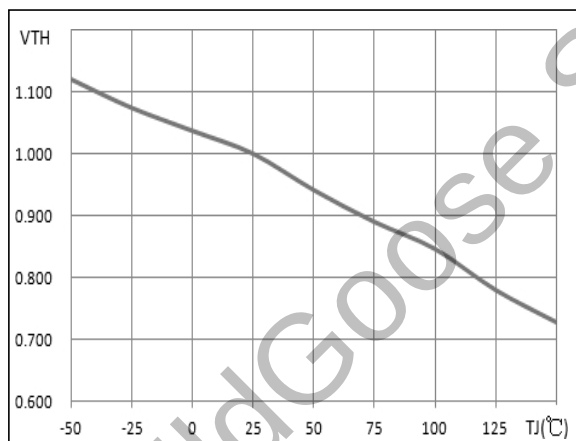
Normalized BVDSS vs. temperature



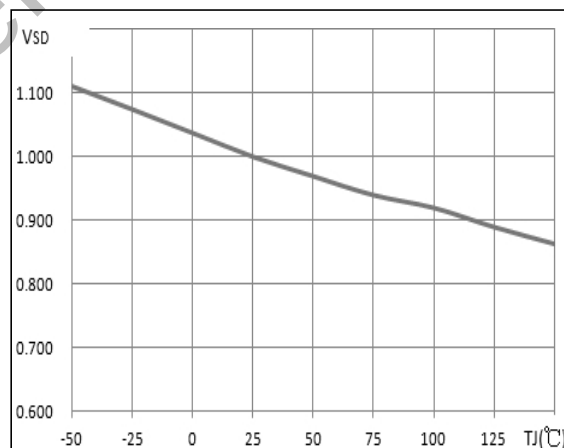
Gate charge vs. VGS



Normalized VTH vs. temperature



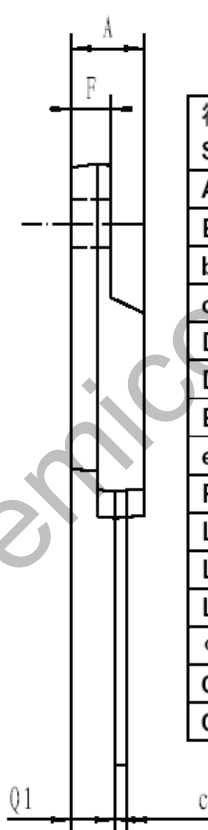
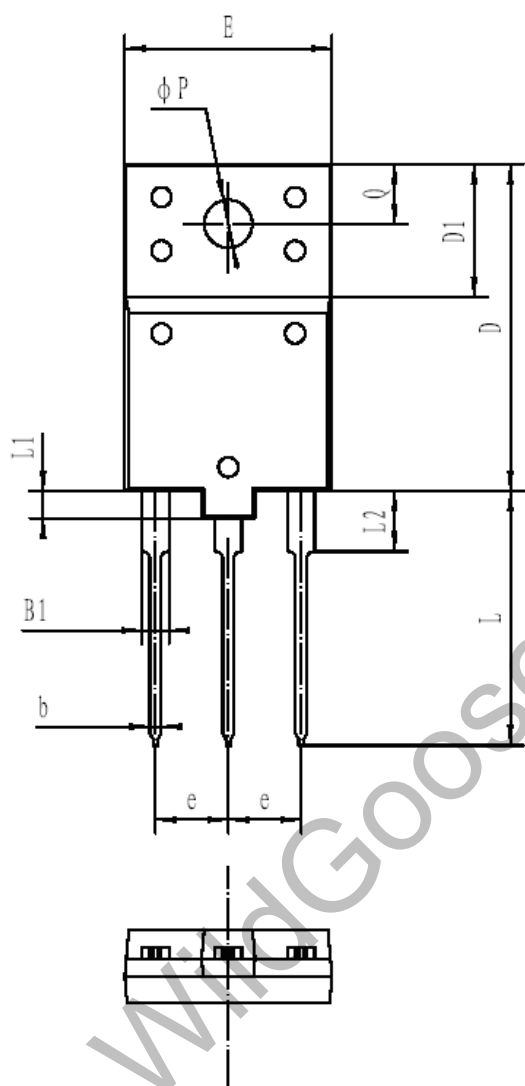
Normalized VSD vs. temperature



Package Dimension

TO-3PF

Unit: mm



符 号 Symbol	Min	Max
A	5.2	5.8
B1	1.8	2.2
b	0.75	1.05
c	0.8	1.1
D	24.0	25.0
D1	9.8	10.2
E	15.0	16.0
e	5.45 (typ)	
F	2.7	3.3
L	18.5	19.5
L1	1.8	2.2
L2	4.3	4.7
ΦP	3.4	3.8
Q	4.3	4.7
Q1	3.1	3.5